Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/824,283	LEE ET AL.
Examiner	Art Unit
Nathan Wiehe	3745

SEARCHED				
Class	Subclass	Date	Examiner	
416	97R,96R, 96A	8/18/2005	NEW	
415	. 115,116	8/18/2005	NEW	
above	updated	2/21/06	në a	
above	updated updated	7/25/06	NEW	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARC		·)
	DATE	EXMR
416/97R,96R,96A 415/115,116 Christopher Verdier	8/18/2005	NEW
Text search (See EAST search history)	8/18/2005	NEW
Inventor Name Search	8/18/2005	NECT
PLUS search	8/18/2005	NEW
above applaced	2/21/06	NEW
Nove upleved	7/25/06	NEW